Search Notes



Application/Control No.	

10666241

Applicant(s)/Patent Under Reexamination

OGAWA ET AL.

Examiner
Patel, Jayesh A

Art Unit

SEVECHED

	SEARCHED		
Class	Subclass	Date	Examiner
382	141,144,145,147	02/28/07	JP
356	500,498,496,450	02/28/07	JP

SEARCH NOTES

Search Notes	Date	Examiner
See attached East Search Report	02/28/07	JP
See updated East (US -pat, PG-pub) IEEE and Inventor search.	11/25/2008	JP

	INTERFERENCE SEAF	СН	
Class	Subclass	Date	Examiner

/J. A. P./ Examiner.Art Unit 2624	

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